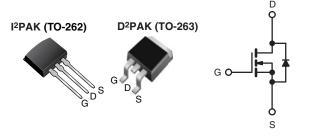


### **Vishay Siliconix**

## Power MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	60					
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 5 V 0.20					
Q <sub>g</sub> (Max.) (nC)	8.4					
Q <sub>gs</sub> (nC)	3.5					
Q <sub>gd</sub> (nC)	6.0					
Configuration	Single					



N-Channel MOSFET

### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Advanced Process Technology
- Surface Mount (IRLZ14S, SiHLZ14S)
- Low-Profile Through-Hole (IRLZ14L, SiHLZ14L)
- 175 °C Operating Temperature
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC

#### DESCRIPTION

Third generation Power MOSFETs from Vishay utilize advanced processing techniques to achieve extermely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that Power MOSFETs are well known for, provides the designer with an extremely efficient reliable device for use in a wide variety of applications.

The D<sup>2</sup>PAK is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and lowest possible on-resistance in any existing surface mount package. The D<sup>2</sup>PAK is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application.

The through-hole version (IRLZ44L, SiHLZ44L) is available for low-profile applications.

	ORDERING INFORMATION								
D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-263)	I <sup>2</sup> PAK (TO-262)						
SiHLZ14S-GE3	SiHLZ14STRL-GE3 <sup>a</sup>	SiHLZ14STRR-GE3 <sup>a</sup>	-						
RLZ14SPbF	-	IRLZ14STRRPbF <sup>a</sup>	IRLZ14LPbF						
SiHLZ14S-E3	-	SiHLZ14STR-E3	SiHLZ14L-E3						
Si	iHLZ14S-GE3 RLZ14SPbF	iHLZ14S-GE3 SIHLZ14STRL-GE3ª RLZ14SPbF -	iHLZ14S-GE3   SiHLZ14STRL-GE3 <sup>a</sup> SiHLZ14STRR-GE3 <sup>a</sup> RLZ14SPbF   -   IRLZ14STRRPbF <sup>a</sup>						

Note

a. See device orientation.

PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage <sup>e</sup>	V <sub>DS</sub>	60	V			
Gate-Source Voltage	V <sub>GS</sub>	± 10	- V			
Continuous Drain Current	V at 5 V	$T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$		10		
Continuous Drain Current	V <sub>GS</sub> at 5 V		I <sub>D</sub>	7.2	А	
Pulsed Drain Current <sup>a, e</sup>	I <sub>DM</sub>	40	1			
Linear Derating Factor		0.29	W/°C			
Single Pulse Avalanche Energy <sup>b, e</sup>	E <sub>AS</sub>	68	mJ			
Maximum Dawar Dissinction	T <sub>C</sub> = 25 °C		P	43	- w	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C T <sub>A</sub> = 25 °C		P <sub>D</sub>	3.7		
Peak Diode Recovery dV/dtc, e	dV/dt	4.5	V/ns			
Operating Junction and Storage Temperature Rang	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C			
Soldering Recommendations (Peak Temperature)	ž	300 <sup>d</sup>				

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 ^{\circ}\text{C}$ ,  $L = 790 \ \mu\text{H}$ ,  $R_g = 25 \Omega$ ,  $I_{AS} = 10 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 10 \text{ A}$ , d/dt  $\le 90 \text{ A/}\mu\text{s}$ ,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175 ^{\circ}\text{C}$ . d. 1.6 mm from case.

Uses IRLZ14, SiHLZ14 data and test conditions.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

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COMPLIANT

HALOGEN

FREE

# Vishay Siliconix



THERMAL RESISTANCE RATINGS								
PARAMETER	SYMBOL	TYP.	MAX.	UNIT				
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	-	40	°C/W				
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	3.5					

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT		
Static		<u>.</u>			•			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	60	-	-	V		
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.07	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	- V <sub>GS</sub> , I <sub>D</sub> = 250 μΑ	1.0	-	2.0	V	
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 10 V	-	-	± 100	nA	
Zaus Osta Valtana Dusin Ourmant		V <sub>DS</sub>	= 60 V, V <sub>GS</sub> = 0 V	-	-	25		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 48 V	-	-	250	μA		
Ducia Courses On Otata Desistance	D	$V_{GS} = 5 V$	I <sub>D</sub> = 6.0 A <sup>b</sup>	-	-	0.2	Ω	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 4 V$	I <sub>D</sub> = 5.0 A <sup>b</sup>	-	-	0.28		
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub>	= 25 V, I <sub>D</sub> = 6.0 A	3.5	-	-	S	
Dynamic		-				-		
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 V$ ,		-	400	-	pF	
Output Capacitance	C <sub>oss</sub>		-	170	-			
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 5		-	42	-		
Total Gate Charge	Qg			-	-	8.4		
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 5 V$ $I_D = 10 A, V_{DS} = 48 V,$ see fig. 6 and 13 <sup>b</sup>		-	-	3.5	nC	
Gate-Drain Charge	Q <sub>gd</sub>				-	6.0		
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 30 V, I <sub>D</sub> = 10 A,		-	9.3	-	- ns	
Rise Time	t <sub>r</sub>			-	110	-		
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_g = 12 \overline{\Omega},$	$R_g = 12 \Omega$ , $R_D = 2.8 \Omega$ , see fig. $10^b$		17	-		
Fall Time	t <sub>f</sub>			-	26	-	1	
Internal Source Inductance	L <sub>S</sub>	Between lead	-	7.5	-	nH		
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	10	A	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	40		
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C	-	-	1.6	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>			-	93	130	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$I_{\rm J} = 25$ C, I <sub>F</sub>	-	340	650	nC		
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	rn-on time is negligible (turn	-on is dor	ninated b	y L <sub>S</sub> and	L <sub>D</sub> )	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

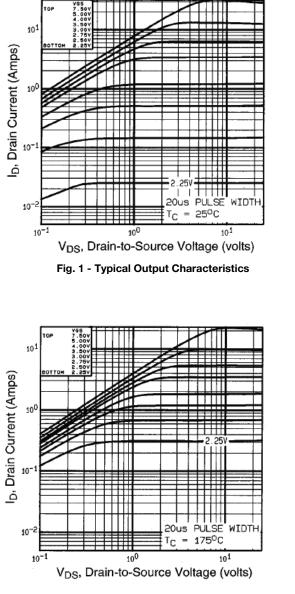
b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.

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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





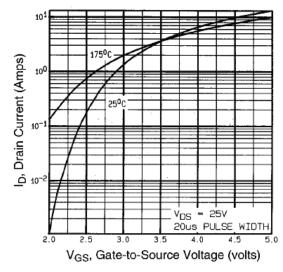


Fig. 3 - Typical Transfer Characteristics

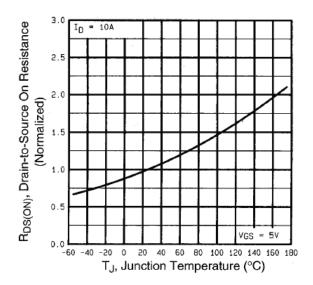


Fig. 4 - Normalized On-Resistance vs. Temperature

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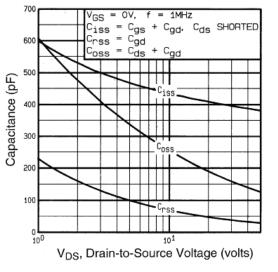


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

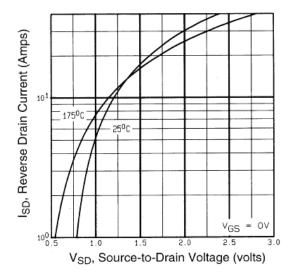


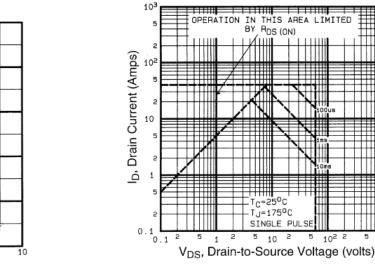
Fig. 7 - Typical Source-Drain Diode Forward Voltage

LIMITED

5 10<sup>2</sup> 2

Fig. 8 - Maximum Safe Operating Area

5 10<sup>3</sup>



10 = 10A ΙD V<sub>GS</sub>, Gate-to-Source Voltage (volts) 48V / DS V DS 30V = CIRCUI FOŔ TEST SEE FIGURE 13 0 6 Q<sub>G</sub>, Total Gate Charge (nC)

Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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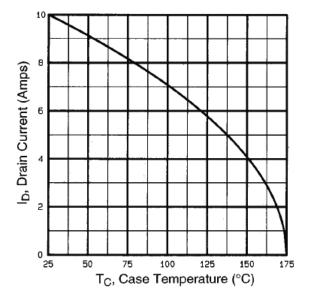


Fig. 9 - Maximum Drain Current vs. Case Temperature

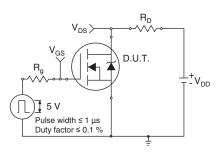


Fig. 10a - Switching Time Test Circuit

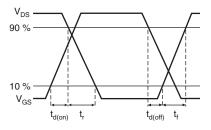


Fig. 10b - Switching Time Waveforms

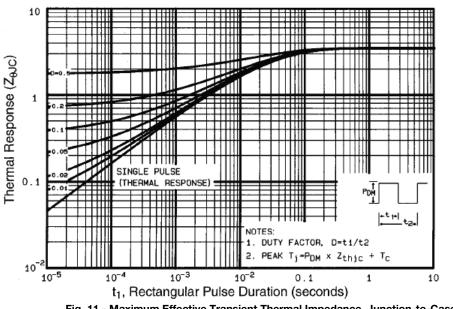


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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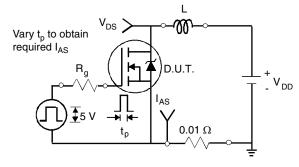


Fig. 12a - Unclamped Inductive Test Circuit

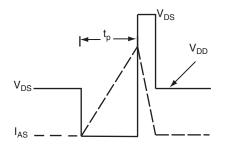


Fig. 12b - Unclamped Inductive Waveforms

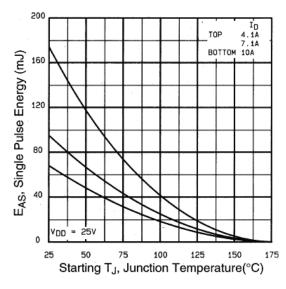
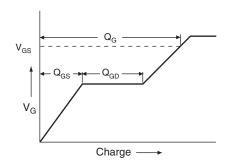


Fig. 12c - Maximum Avalanche Energy vs. Drain Current





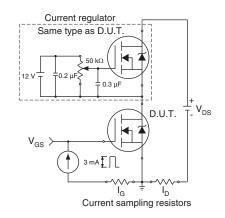
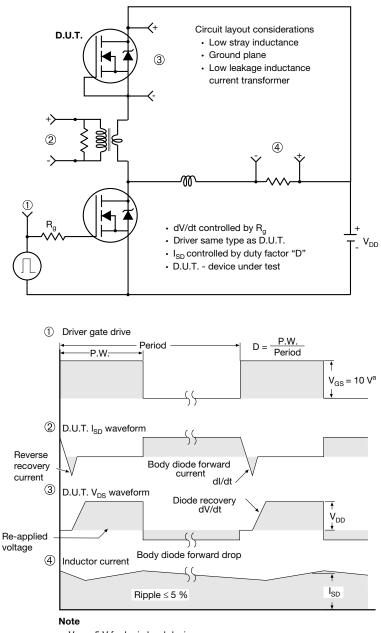


Fig. 13b - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit

a.  $V_{GS}$  = 5 V for logic level devices

Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="http://www.vishay.com/ppg290414">www.vishay.com/ppg290414</a>.

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H

A1

B

Gauge plane

L3

Detail "A" Rotated 90° CW scale 8:1

0° tọ 8°

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Seating plane

### TO-263AB (HIGH VOLTAGE)

3 /4

A

н

<--2 x b2 ---2 x b Detail A

с

(Datum A)

D

<u>4</u> Lī

		2 x P + + + + + + + + + + + + + + + + + +	∲ 0.010@ A( ₽	Itating   5     b1, b     (c)     (c)  (c)     (c)     (c)     (c)     (c)     (c)     (c)     (c)     (c)     (c)     (c)     (c)     (c)     (c)     (c)      (c)	$\begin{array}{c} c_{1} \\ c_{1} \\ c_{2} \\ c_{3} \\ c_{4} \\ c_{5} \\ c_{7} \\$			E1	1 <u>4</u>	
	MILLIMETERS INCHES				MILLIMETERS		INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		DIM.	MIN.	MAX.	MIN.	MAX.
А	4.06	4.83	0.160	0.190		D1	6.86	-	0.270	-
A1	0.00	0.25	0.000	0.010		Е	9.65	10.67	0.380	0.420
b	0.51	0.99	0.020	0.039		E1	6.22	-	0.245	-
b1	0.51	0.89	0.020	0.035		е	2.54 BSC		0.100 BSC	
b2	1.14	1.78	0.045	0.070		Н	14.61	15.88	0.575	0.625
b3	1.14	1.73	0.045	0.068		L	1.78	2.79	0.070	0.110
С	0.38	0.74	0.015	0.029		L1	-	1.65	-	0.066
c1	0.38	0.58	0.015	0.023		L2	-	1.78	-	0.070
c2	1.14	1.65	0.045	0.065		L3	0.25	BSC	0.010	) BSC
D	8.38	9.65	0.330	0.380		L4	4.78	5.28	0.188	0.208
ECN: S-82 DWG: 597	110-Rev. A, <sup>-</sup> 0	15-Sep-08	1						1	

Α

Notes

2. Dimensions are shown in millimeters (inches).

3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.

4. Thermal PAD contour optional within dimension E, L1, D1 and E1.

- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

<sup>1.</sup> Dimensioning and tolerancing per ASME Y14.5M-1994.



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